

Notice of References Cited	Application/Control No. 10/642,631	Applicant(s)/Patent Under Reexamination TOKUDA ET AL.	
	Examiner Michael J. Zanelli	Art Unit 3661	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2003/0232696	12-2003	Shibagaki, Nobuyuki	477/76
	B	US-2001/0049575	12-2001	Muratomi, Yoshinori	701/62
	C	US-6,270,443	08-2001	Ito et al.	477/114
	D	US-6,039,673	03-2000	Mikami et al.	477/93
	E	US-5,704,873	01-1998	Iwata et al.	477/115
	F	US-6,645,122	11-2003	Ishiguro et al.	477/120
	G	US-6,533,704	03-2003	Saito et al.	477/92
	H	US-5,369,581	11-1994	Ohsuga et al.	701/48
	I	US-6,352,061	03-2002	Takahashi, Shunichi	123/90.15
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP2000-205393	07-2000	Japan	-----	-----
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.